



PATENT

Docket No.: UC0000061-2

Applicant or Patentee: ALI SHAKOURI; PEYMAN MILANFAR; KENNETH PEDROTTI; JAMES CHRISTOFFERSON  
Serial or Patent No.: 10/039,290  
Filed or Issued: JANUARY 4, 2002  
For: SUBMICRON THERMAL IMAGING METHOD AND ENHANCED RESOLUTION (SUPER-RESOLVED) AC-COUPLED IMAGING FOR THERMAL INSPECTION OF INTEGRATED CIRCUITS

Group:  
Examiner:

**POWER OF ATTORNEY BY ASSIGNEE  
AND EXCLUSION OF INVENTOR(S) UNDER 37 C.F.R. 3.71**

Dear Sir:

The undersigned assignee of the entire interest in the above-identified subject application hereby appoints

**John P. O'Banion, Reg. No. 33,201**

as its attorney to prosecute this application and to transact all business in the United States Patent and Trademark Office connected therewith, said appointment to be to the exclusion of the inventors and their attorney(s) in accordance with the provisions of 37 C.F.R. 3.71.

An assignment of the entire interest in the above-identified subject application:

☐ was recorded on \_\_\_\_\_ at reel/frame \_\_\_\_\_/\_\_\_\_\_.

☒ is submitted herewith for recording.

Please direct all telephone calls to John P. O'Banion at (916) 498-1010 and all correspondence relative to said application to the following address:

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Dated: February 22, 2002

ASSIGNEE: THE REGENTS OF THE UNIVERSITY OF CALIFORNIA

Signature: 

Typed Name: Oren Livne

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